

# **MOSFET** - Power, Single **N-Channel** 100 V, 3.1 mΩ, 169 A

# NVMFWS003N10MC

#### **Features**

- Small Footprint (5x6 mm) for Compact Design
- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Q<sub>G</sub> and Capacitance to Minimize Driver Losses
- AEC-Q101 Qualified and PPAP Capable
- Wettable Flank Product
- These Devices are Pb-Free, Halogen Free/BFR Free, Beryllium Free and are RoHS Compliant

# MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V <sub>DSS</sub>	100	٧
Gate-to-Source Voltage	Э		V <sub>GS</sub>	±20	٧
Continuous Drain		T <sub>C</sub> = 25°C	I <sub>D</sub>	169	Α
Current R <sub>θJC</sub> (Note 1)	Steady	T <sub>C</sub> = 100°C	1	119	
Power Dissipation	State			194	W
R <sub>θJC</sub> (Note 1)		T <sub>C</sub> = 100°C	1	97	
Continuous Drain		T <sub>A</sub> = 25°C	I <sub>D</sub>	23.7	Α
Current R <sub>θJA</sub> (Notes 1, 2)	Steady	T <sub>A</sub> = 100°C		16.8	
Power Dissipation	State $T_A = 25^{\circ}C$		$P_{D}$	3.8	W
R <sub>θJA</sub> (Notes 1, 2)		T <sub>A</sub> = 100°C		1.9	
Pulsed Drain Current	$T_A = 25^{\circ}C, t_p = 10 \mu s$		I <sub>DM</sub>	900	Α
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	-55 to +175	°C	
Source Current (Body Diode)		I <sub>S</sub>	149	Α	
Single Pulse Drain-to-Source Avalanche Energy (I <sub>L(pk)</sub> = 11.9 A)		E <sub>AS</sub>	1307	mJ	
Lead Temperature Soldering Reflow for Soldering Purposes (1/8" from case for 10 s)				260	°C

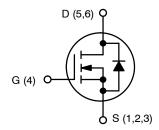
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

#### THERMAL RESISTANCE RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State (Note 1)	$R_{\theta JC}$	0.77	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	39	

The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
100 V	3.1 mΩ @ 10 V	169 A



**N-CHANNEL MOSFET** 

#### DFNW5 CASE 507BA

ZZ

#### **MARKING** DIAGRAM



XXXXXX = Specific Device Code

= Assembly Location Α = Year W = Work Week

#### ORDERING INFORMATION

= Lot Traceability

Device	Package	Shipping†
NVMFWS003N10MCT1G	DFNW5 (Pb-Free)	1500 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

<sup>2.</sup> Surface-mounted on FR4 board using 1 in<sup>2</sup> pad size, 2 oz. Cu pad.

# **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS				•	•		-
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA		100			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /	I <sub>D</sub> = 250 μA, ref to 25°C			50		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	VG9 = 0 V.	Voc = 0 V T <sub>J</sub> = 25°C			1	μΑ
		$V_{GS} = 0 \text{ V}, V_{DS} = 100 \text{ V}$	T <sub>J</sub> = 125°C			100	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = 20 V				100	nA
ON CHARACTERISTICS				•	•		•
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D =$	= 351 μA	2		4	V
Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>	I <sub>D</sub> = 250 μA, ref	to 25°C		-9.3		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub>	= 50 A		2.6	3.1	mΩ
Forward Transconductance	9FS	V <sub>DS</sub> = 10 V, I <sub>D</sub>	= 50 A		150		S
Gate-Resistance	R <sub>G</sub>	T <sub>A</sub> = 25°	С		0.40		Ω
CHARGES & CAPACITANCES	<u>'</u>			1			
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = 50 V			4650		pF
Output Capacitance	C <sub>OSS</sub>				2400		
Reverse Transfer Capacitance	C <sub>RSS</sub>				33		
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 50 V, I <sub>D</sub> = 50 A			62		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>				14		1
Gate-to-Source Charge	Q <sub>GS</sub>				22		
Gate-to-Drain Charge	$Q_{GD}$				10		
Plateau Voltage	V <sub>GP</sub>				5		V
SWITCHING CHARACTERISTICS (Note	3)			1			
Turn-On Delay Time	t <sub>d(ON)</sub>	$V_{GS}$ = 10 V, $V_{DS}$ = 50 V, $I_{D}$ = 50 A, $R_{G}$ = 6 $\Omega$			28		ns
Rise Time	t <sub>r</sub>				15		1
Turn-Off Delay Time	t <sub>d(OFF)</sub>				46		
Fall Time	t <sub>f</sub>				14		
DRAIN-SOURCE DIODE CHARACTER	STICS			1			
Forward Diode Voltage	$V_{SD}$	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 50 A	T <sub>J</sub> = 25°C		0.80	1.3	V
			T <sub>J</sub> = 125°C		0.67		1
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS} = 0 \text{ V, } dI_S/dt = 100 \text{ A/}\mu\text{s,}$			72		ns
Reverse Recovery Charge	Q <sub>RR</sub>				91		nC
Charge Time	t <sub>a</sub>				ns		
Discharge Time	t <sub>b</sub>				38		ns

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

3. Switching characteristics are independent of operating junction temperatures

#### **TYPICAL CHARACTERISTICS**

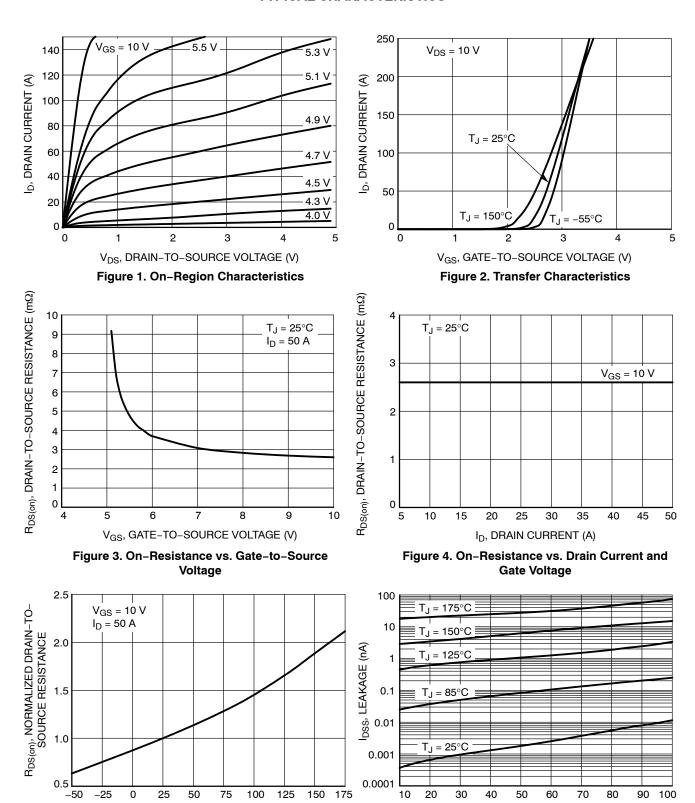


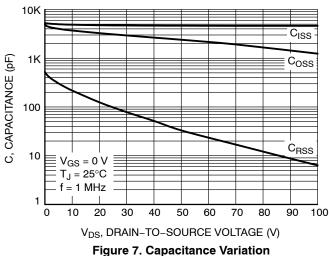
Figure 5. On–Resistance Variation with Temperature

T<sub>J</sub>, JUNCTION TEMPERATURE (°C)

Figure 6. Drain-to-Source Leakage Current vs. Voltage

V<sub>DS</sub>, DRAIN-TO-SOURCE VOLTAGE (V)

#### **TYPICAL CHARACTERISTICS**



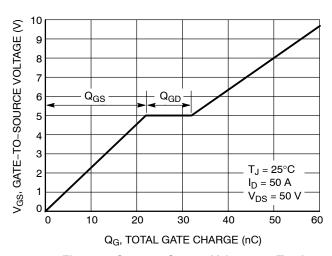


Figure 8. Gate-to-Source Voltage vs. Total Charge

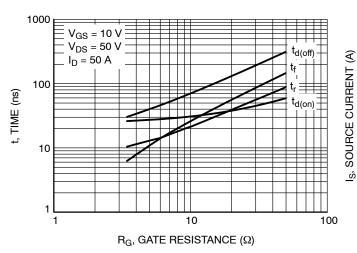


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

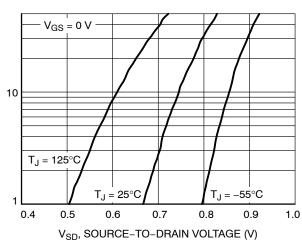


Figure 10. Diode Forward Voltage vs. Current

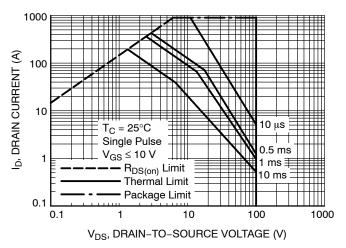


Figure 11. Maximum Rated Forward Biased Safe Operating Area

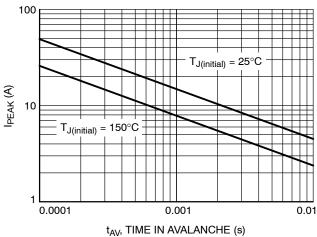


Figure 12. Maximum Drain Current vs. Time in **Avalanche** 

# **TYPICAL CHARACTERISTICS**

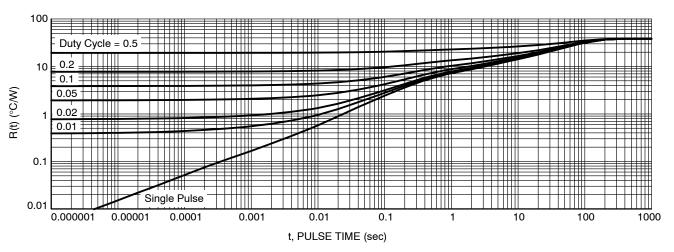
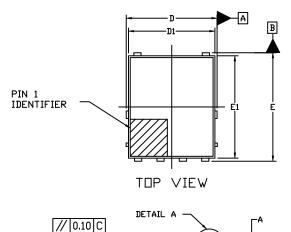


Figure 13. Transient Thermal Impedance

#### PACKAGE DIMENSIONS

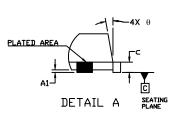
## DFNW5 5x6 (FULL-CUT SO8FL WF)

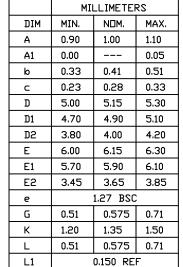
#### CASE 507BA **ISSUE A**

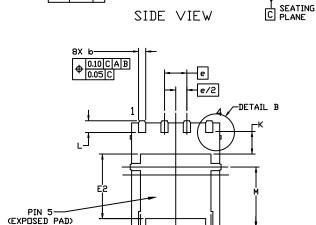




- NOTES:
  1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
  2. CONTROLLING DIMENSION: MILLIMETERS
  3. DIMENSIONS D1 AND E1 DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.
  4. THIS PACKAGE CONTAINS WETTABLE FLANK DESIGN FEATURES TO AID IN FILLET FORMATION ON THE LEADS DURING MOUNTING.

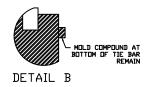






BOTTOM VIEW

0.10 C



2X 0.4950	4.56 <del></del>
PACKAGE 2X 0.475 2X 0.905 0.965 4X 1.00 1	3.20 4.53 1.33 1.27 PITCH

М

θ

3.00

0°

3.40

3.80

12\*

## RECOMMENDED MOUNTING FOOTPRINT

For additional information on our Pb-Free strategy and soldering details, please download the DN Semiconductor Soldering and Mounting Techniques Reference Manual, SDLDERRM/D.

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